

BUK9C07-65BIT

N-channel TrenchPLUS logic level FET

Rev. 03 — 15 July 2010

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode field-effect power transistor in SOT427. Device is manufactured using NXP High-Performance TrenchPLUS technology, featuring very low on-state resistance, integrated current sensing transistor and over temperature protection diodes.

1.2 Features and benefits

- AEC-Q101 compliant
- Low conduction losses due to low on-state resistance

1.3 Applications

- Lamp switching
- Motor drive systems
- Power distribution
- Solenoid drivers

1.4 Quick reference data

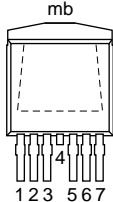
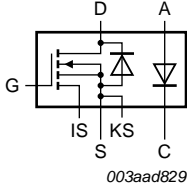
Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 5\text{ V}$; $I_D = 25\text{ A}$; $T_j = 25\text{ °C}$; see Figure 12 ; see Figure 13	-	6	7	mΩ
I_D/I_{sense}	ratio of drain current to sense current	$T_j = 25\text{ °C}$; $V_{GS} = 5\text{ V}$; see Figure 14	1086 1	1206 8	1327 5	A/A
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250\text{ }\mu\text{A}$; $V_{GS} = 0\text{ V}$; $T_j = 25\text{ °C}$	65	-	-	V



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	 <p style="text-align: center;">SOT427 (D2PAK)</p>	 <p style="text-align: center;"><small>003aad829</small></p>
2	IS	current sense		
3	A	anode		
4	D	drain		
5	K	cathode		
6	KS	Kelvin source		
7	S	source		
mb	D	mb		

3. Ordering information

Table 3. Ordering information

Type number	Package		Version
	Name	Description	
BUK9C07-65BIT	D2PAK	plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)	SOT427

4. Limiting values

Table 4. Limiting values

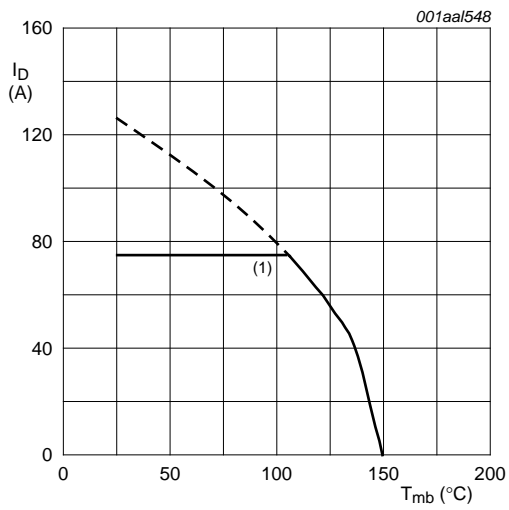
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	65	V
V_{DGR}	drain-gate voltage	$R_{GS} = 20\text{ k}\Omega$; $25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	65	V
V_{GS}	gate-source voltage		-15	15	V
I_D	drain current	$V_{GS} = 5\text{ V}$; $T_{mb} = 25\text{ °C}$; see Figure 1 ^[1]	-	75	A
		$V_{GS} = 5\text{ V}$; $T_{mb} = 100\text{ °C}$; see Figure 1 ^[1]	-	75	A
I_{DM}	peak drain current	$T_{mb} = 25\text{ °C}$; single pulse; $t_p \leq 10\text{ }\mu\text{s}$; see Figure 4	-	550	A
P_{tot}	total power dissipation	$T_{mb} = 25\text{ °C}$; see Figure 2	-	245	W
T_{stg}	storage temperature		-55	150	°C
T_j	junction temperature		-55	150	°C
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage		-	100	V
Source-drain diode					
I_S	source current	$T_{mb} = 25\text{ °C}$ ^[1]	-	75	A
I_{SM}	peak source current	single pulse; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$	-	550	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$I_D = 75\text{ A}$; $V_{sup} = 65\text{ V}$; $V_{GS} = 5\text{ V}$; $T_{j(init)} = 25\text{ °C}$; unclamped; see Figure 3 ^{[2][3]}	-	0.605	J
Electrostatic discharge					
V_{ESD}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ; all pins	-	0.15	kV
		HBM; C = 100 pF; R = 1.5 kΩ; pin 4 to pin 7	-	4	kV

[1] Current is limited by package.

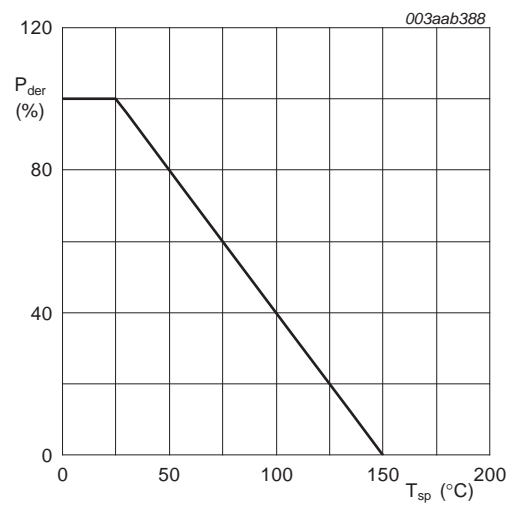
[2] Single-pulse avalanche rating limited by maximum junction temperature of 150 °C.

[3] Refer to application note AN10273 for further information.



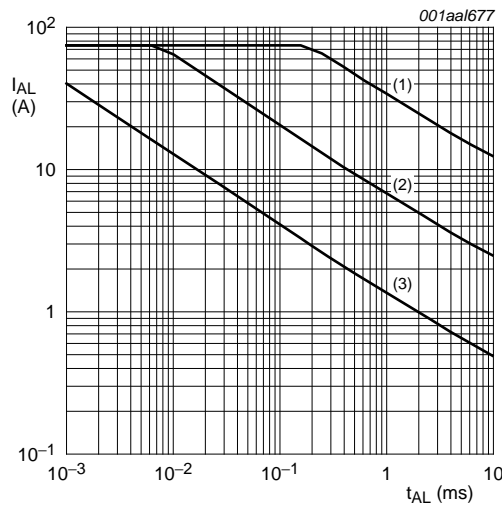
$$V_{GS} \geq 5V$$

Fig 1. Continuous drain current as a function of solder point temperature.



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of solder point temperature



- (1) Single-pulse; $T_j = 25^{\circ}C$.
- (2) Single-pulse; $T_j = 150^{\circ}C$.
- (3) Repetitive.

Fig 3. Single-Pulse and repetitive avalanche rating; avalanche current as a function of avalanche time.

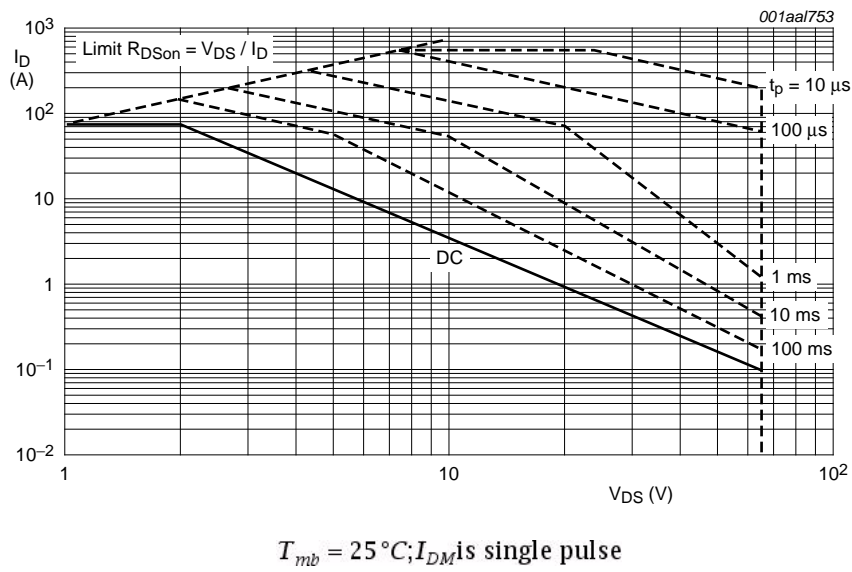


Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	-	0.51	K/W

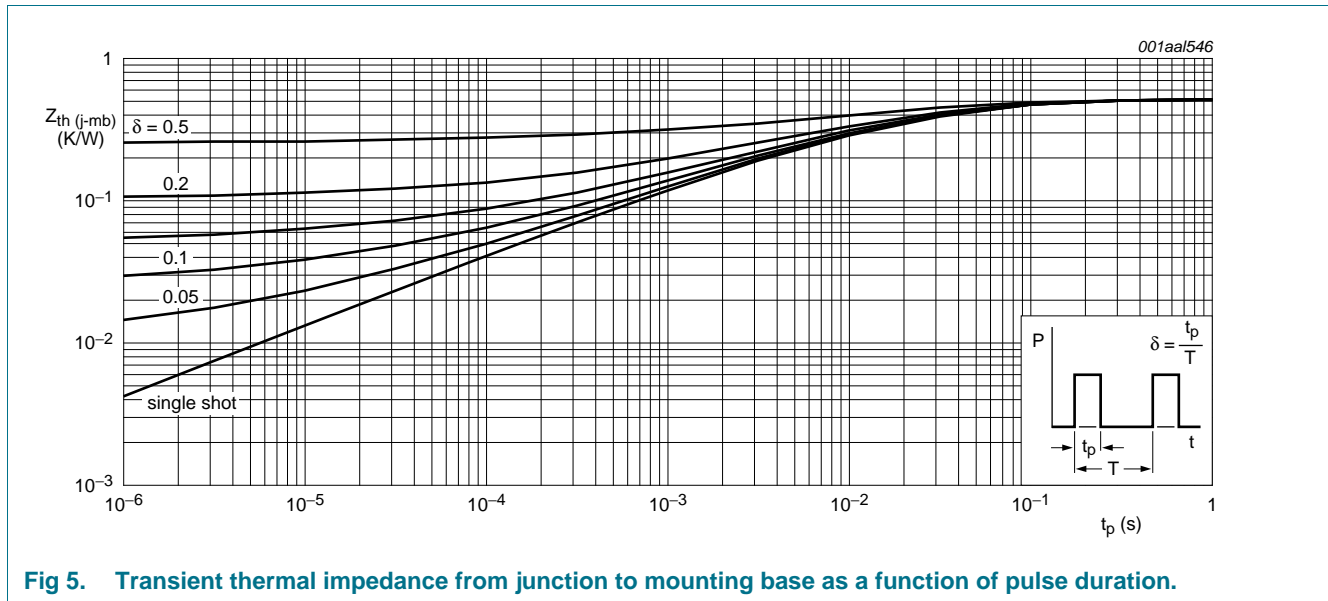


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration.

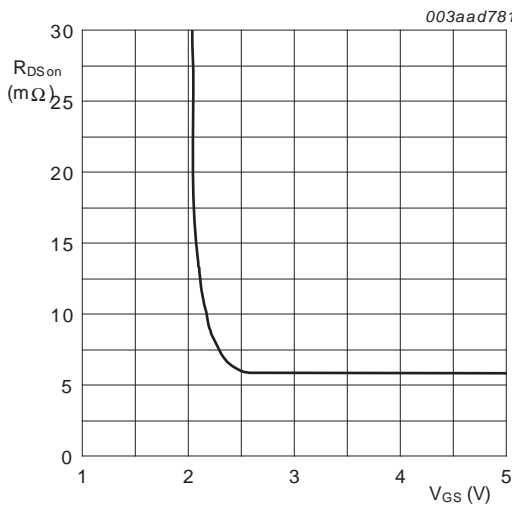
6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$	65	-	-	V
		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 \text{ }^\circ C$	59	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ }^\circ C$; see Figure 10 ; see Figure 11	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ }^\circ C$; see Figure 10 ; see Figure 11	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ }^\circ C$; see Figure 10 ; see Figure 11	-	-	2.3	V
I_{DSS}	drain leakage current	$V_{DS} = 52 V; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$	-	0.02	3	μA
		$V_{DS} = 52 V; V_{GS} = 0 V; T_j = 150 \text{ }^\circ C$	-	-	125	μA
I_{GSS}	gate leakage current	$V_{DS} = 0 V; V_{GS} = 15 V; T_j = 25 \text{ }^\circ C$	-	2	300	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 \text{ }^\circ C$; see Figure 12 ; see Figure 13	-	-	7.6	m Ω
		$V_{GS} = 5 V; I_D = 25 A; T_j = 25 \text{ }^\circ C$; see Figure 12 ; see Figure 13	-	6	7	m Ω
		$V_{GS} = 5 V; I_D = 25 A; T_j = 150 \text{ }^\circ C$; see Figure 12 ; see Figure 13	-	-	13.5	m Ω
		$V_{GS} = 10 V; I_D = 25 A; T_j = 25 \text{ }^\circ C$; see Figure 12 ; see Figure 13	-	-	6.5	m Ω
I_D/I_{sense}	ratio of drain current to sense current	$V_{GS} = 5 V; T_j = 25 \text{ }^\circ C$; see Figure 14	10861	12068	13275	A/A
$S_{F(TSD)}$	temperature sense diode temperature coefficient	$I_F = 250 \mu A; 25 \text{ }^\circ C \leq T_j \leq 150 \text{ }^\circ C$; see Figure 15	-5.4	-5.7	-6	mV/K
$V_{F(TSD)}$	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 \text{ }^\circ C$; see Figure 15	2.855	2.9	2.945	V
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 25 A; V_{DS} = 52 V; V_{GS} = 5 V$; see Figure 16	-	102.8	-	nC
Q_{GS}	gate-source charge		-	16.4	-	nC
Q_{GD}	gate-drain charge		-	36.4	-	nC
C_{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ C$; see Figure 17	-	7127	-	pF
C_{oss}	output capacitance		-	900	-	pF
C_{rss}	reverse transfer capacitance		-	354	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 30 V; R_L = 1.2 \text{ } \Omega; V_{GS} = 5 V; R_{G(ext)} = 10 \text{ } \Omega$	-	59	-	ns
t_r	rise time		-	180	-	ns
$t_{d(off)}$	turn-off delay time		-	328	-	ns
t_f	fall time		-	173	-	ns
L_D	internal drain inductance	from pin to center of die	-	0.9	-	nH
L_S	internal source inductance	from source lead to source bonding pad	-	2	-	nH

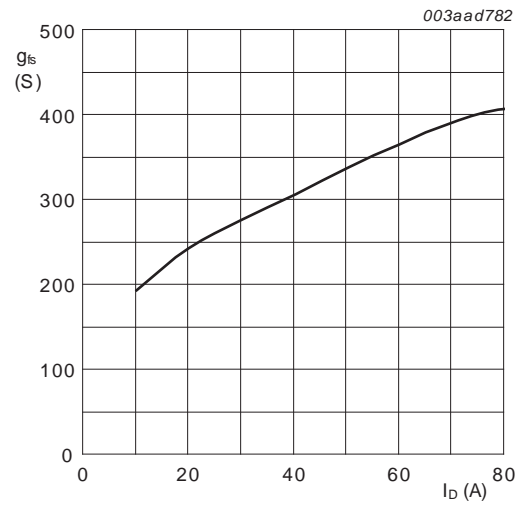
Table 6. Characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 25\text{ A}$; $V_{GS} = 0\text{ V}$; $T_j = 25\text{ °C}$; see Figure 18	-	0.85	1.2	V
t_{rr}	reverse recovery time	$I_S = 10\text{ A}$; $di_S/dt = -100\text{ A}/\mu\text{s}$;	-	60.1	-	ns
Q_r	recovered charge	$V_{GS} = -10\text{ V}$; $V_{DS} = 30\text{ V}$	-	0.161	-	nC



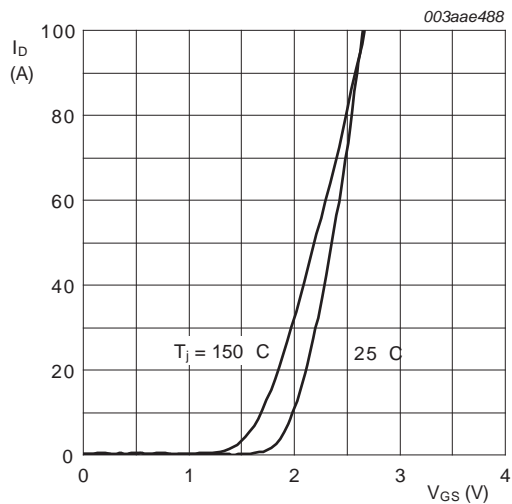
$T_j = 25\text{ °C}$; $I_D = 25\text{ A}$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage



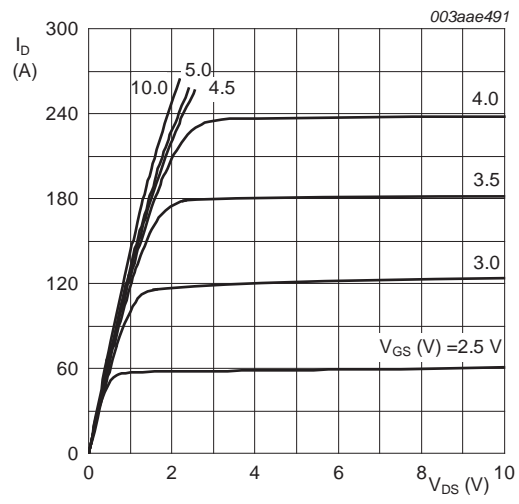
$T_j = 25\text{ °C}$; $V_{DS} = 25\text{ V}$

Fig 7. Forward transconductance as a function of drain current; typical values



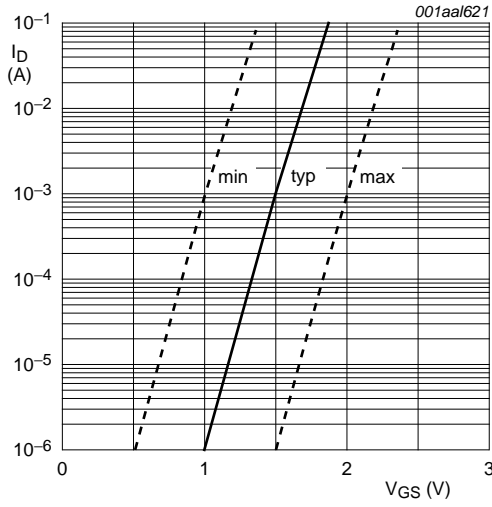
$V_{DS} = 25\text{ V}$

Fig 8. Transfer characteristics; drain current as a function of gate-source voltage



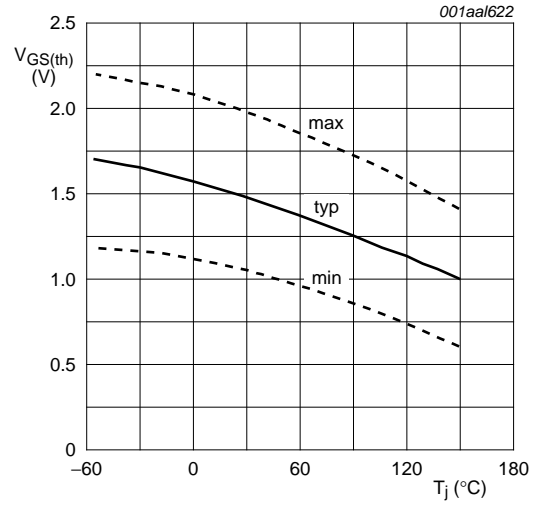
$T_j = 25\text{ °C}$; $t_p = 300\mu\text{s}$

Fig 9. Output characteristics: drain current as a function of drain-source voltage; typical values.



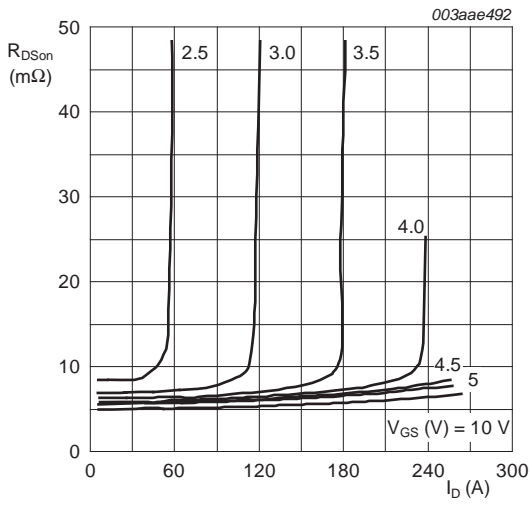
$$T_j = 25^\circ\text{C}; V_{DS} = V_{GS}$$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



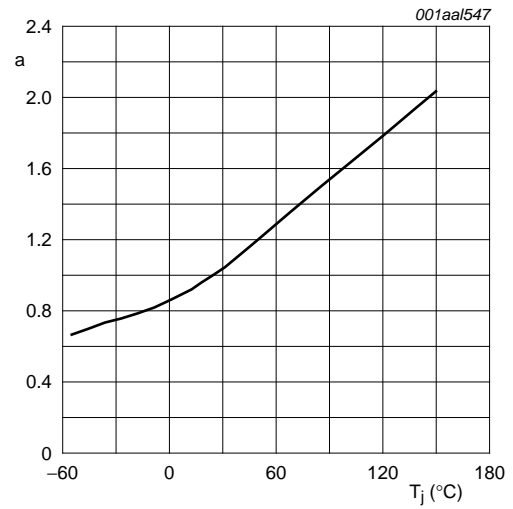
$$I_D = 1\text{mA}; V_{DS} = V_{GS}$$

Fig 11. Gate-source threshold voltage as a function of junction temperature.



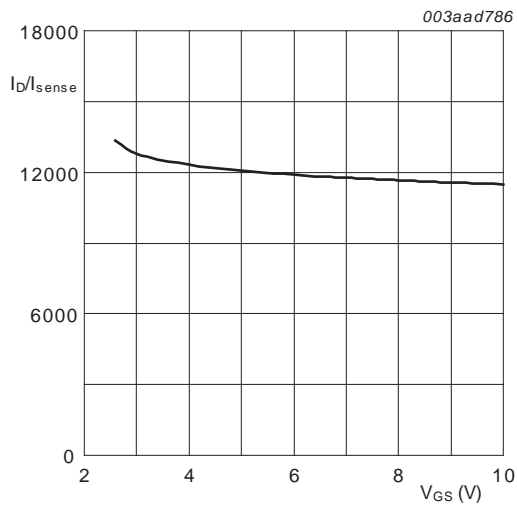
$$T_j = 25^\circ\text{C}; t_p = 300\mu\text{s}$$

Fig 12. Drain-source on-state resistance as a function of drain current



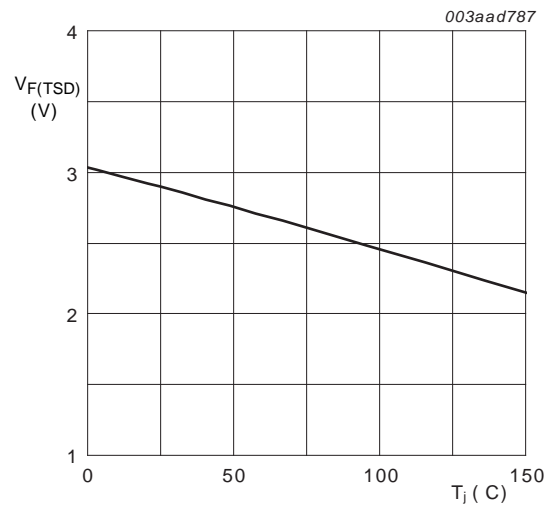
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ\text{C})}}$$

Fig 13. Normalized Drain-Source on-state resistance factor as a function of junction temperature.



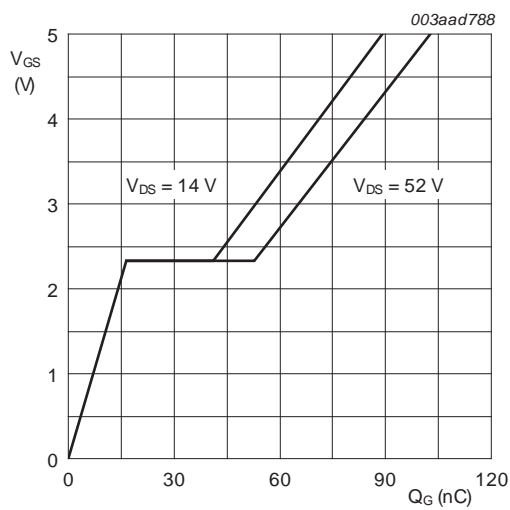
$T_j = 25^\circ C; I_D = 5A$

Fig 14. Ratio of drain current to sense current as a function of gate-source voltage



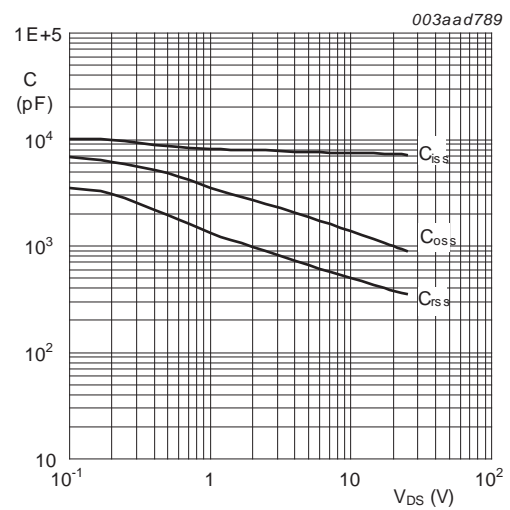
$I_F = 250\mu A$

Fig 15. Temperature sense diode forward voltage as a function of junction temperature



$T_j = 25^\circ C; I_D = 25A$

Fig 16. Gate-source voltage as a function of turn-on gate charge



$V_{GS} = 0V; f = 1MHz$

Fig 17. Input, output and reverse transfer capacitances as a function of drain-source voltage

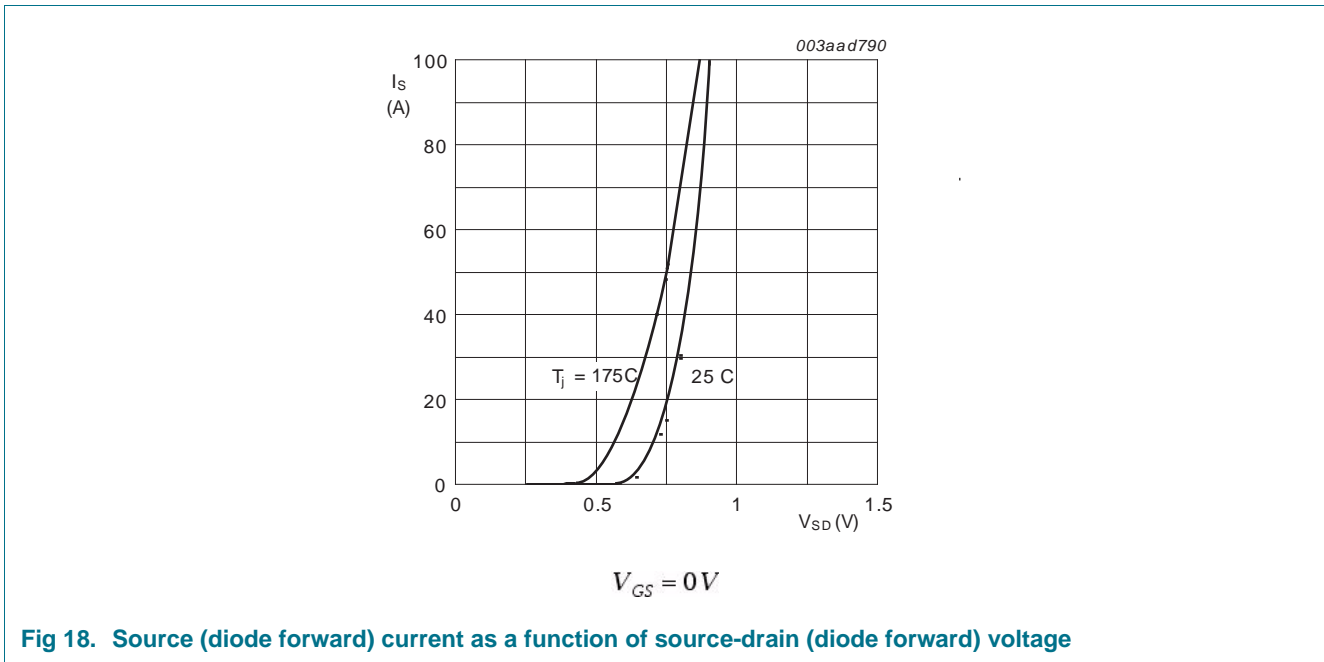


Fig 18. Source (diode forward) current as a function of source-drain (diode forward) voltage

7. Package outline

Plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)

SOT427

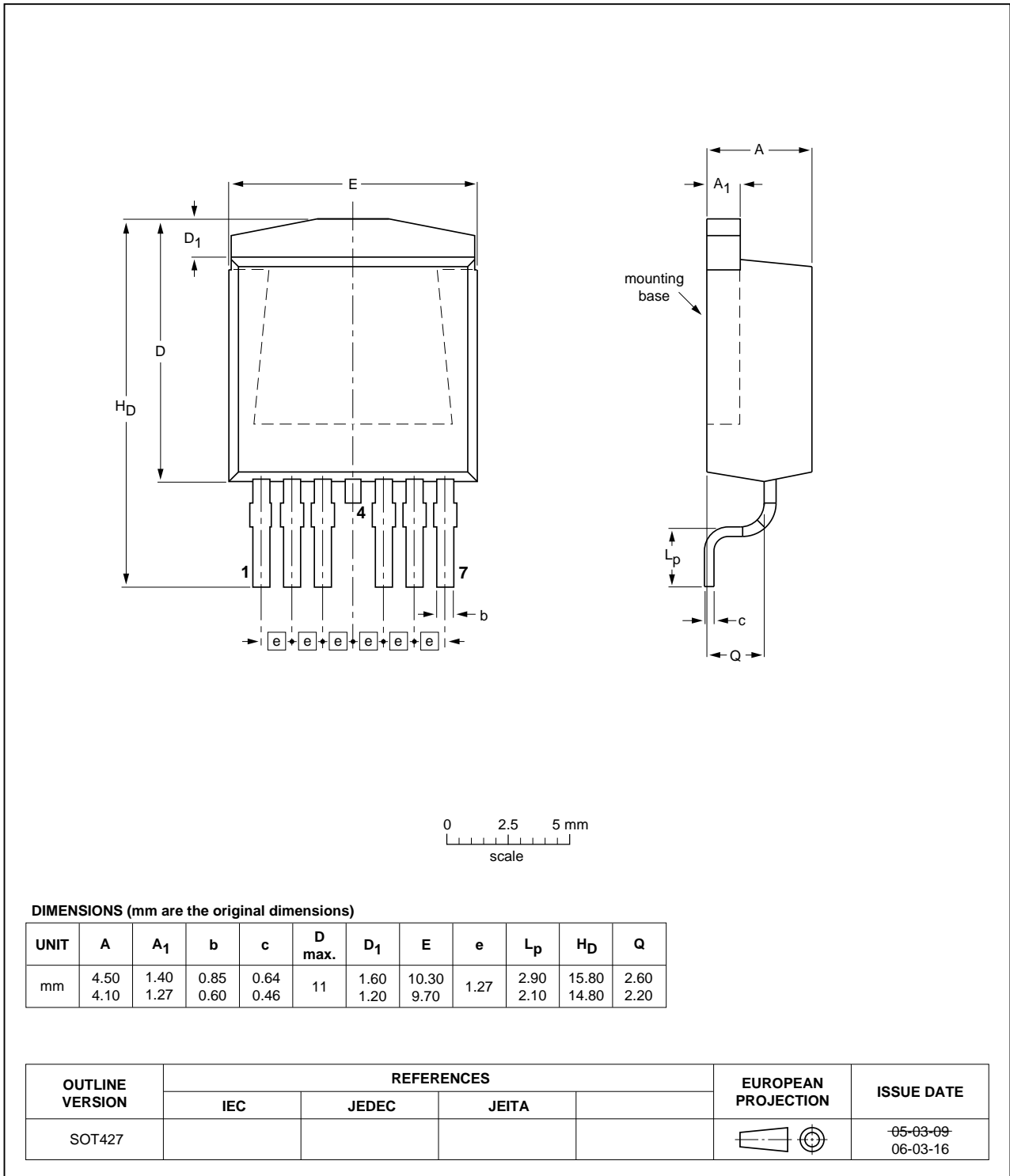


Fig 19. Package outline SOT427 (D2PAK)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9C07-65BIT v.3	20100715	Product data sheet	-	BUK9C07-65BIT v.2
Modifications:	• Various changes to content.			
BUK9C07-65BIT v.2	20100617	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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